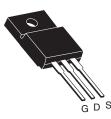


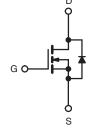
Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.85			
Q _g (Max.) (nC)	39				
Q _{gs} (nC)	10				
Q _{gd} (nC)	19				
Configuration	Single				

TO-220 FULLPAK





N-Channel MOSFET

FEATURES

- · Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- · Repetitve Avalanche Rated
- · Lead (Pb)-free Available

DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology, the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability that are characteristic of MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-220 FULLPAK eliminates the need for additional insulating hardware. The molding compound used provides a high isolation capability and low thermal resistance between the tab and external heatsink.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI840GLCPbF
	SiHFI840GLC-E3
SnPb	IRFI840GLC
	SiHFI840GLC

ABSOLUTE MAXIMUM RATINGS T	c = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	4.5		
	V _{GS} at 10 V	T _C = 100 °C		2.9	А	
Pulsed Drain Current ^a			I _{DM}	18	1	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	300	mJ	
Repetitive Avalanche Currenta			I _{AR}	4.5	A	
Repetitive Avalanche Energy ^a			E _{AR}	4.0	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	40	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		TJ, T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		0	300 ^d	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 26 mH, $R_G = 25 \Omega$, $I_{AS} = 4.5 \text{ A}$ (see fig. 12). c. $I_{SD} \le 8.0 \text{ A}$, dl/dt $\le 100 \text{ A}/\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP.	•	MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65			°C/W				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				0,11			
SPECIFICATIONS $T_J = 25 \degree C$,	unless otherv	vise noted							
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNI	
Static		•						•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μA	500	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.63	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 2$	250 μΑ	2.0	-	4.0	V	
Gate-Source Leakage	I _{GSS}	١	$V_{\rm GS} = \pm 20^{\circ}$	V	-	-	± 100	nA	
Zara Cata Valtaga Drain Current		V _{DS} =	$V_{DS} = 500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 400 V	, V _{GS} = 0 V	, T _J = 125 °C	-	-	250	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D	= 2.7 A ^b	-	-	0.85	mΩ	
Forward Transconductance	g _{fs}	V _{DS} =	= 50 V, I _D =	4.8 A ^b	4.0	-	-	S	
Dynamic									
Input Capacitance	Ciss	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz$		-	1100	-	рF		
Output Capacitance	C _{oss}			-	170	-			
Reverse Transfer Capacitance	C _{rss}			-	18	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg		$V_{GS} = 10 V$ $I_D = 8.0 A, V_{DS} =$		-	-	39	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		0 A, V _{DS} = 400 V fig. 6 and 13 ^b	-	-	10		
Gate-Drain Charge	Q _{gd}					-	19		
Turn-On Delay Time	t _{d(on)}				-	12	-		
Rise Time	t _r		250 V, I _D =		-	25	-	1	
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 9.1\Omega_{,}$	$R_{G} = 9.1\Omega$, $Rr_{D}= 30 \Omega$, $V_{GS} = 10 V$, see fig. 10^{b}		-	27	-	ns	
Fall Time	t _f		5		-	19	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L _S			-	7.5	-			
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S		MOSFET symbol		-	-	4.5		
Pulsed Diode Forward Current ^a	I _{SM}	showing the integral reverse p - n junction diode		-	-	18	A		
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 4.5 A, V _{GS} = 0 V ^b		-	-	2.0	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 8.0 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	490	740	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.0	4.5	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on							

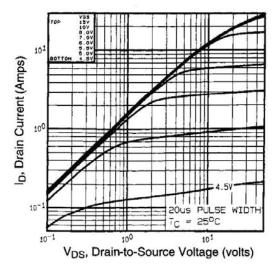
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



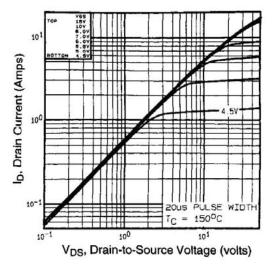


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

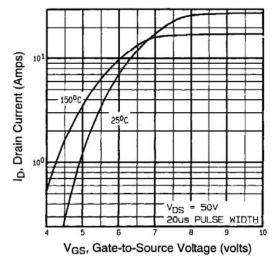


Fig. 3 - Typical Transfer Characteristics

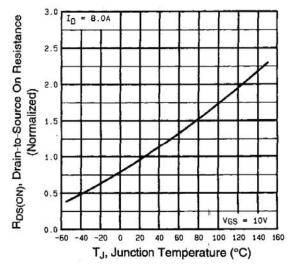
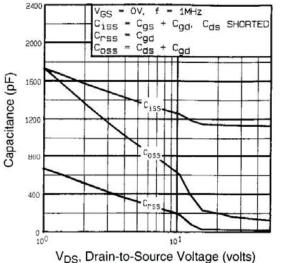
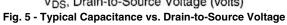


Fig. 4 - Normalized On-Resistance vs. Temperature

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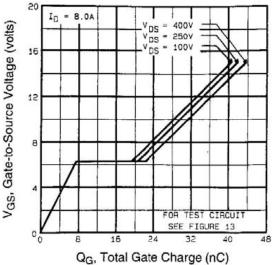
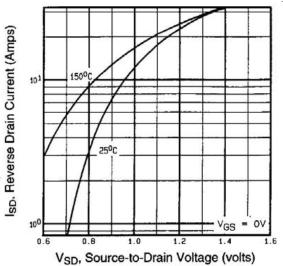
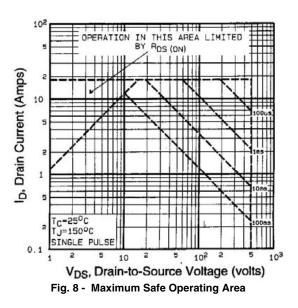


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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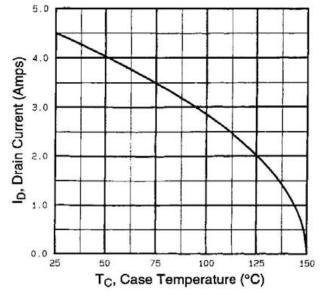


Fig. 9 - Maximum Drain Current vs. Case Temperature

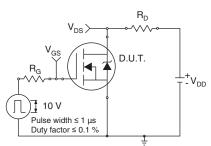


Fig. 10a - Switching Time Test Circuit

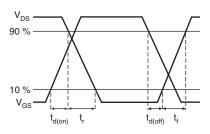
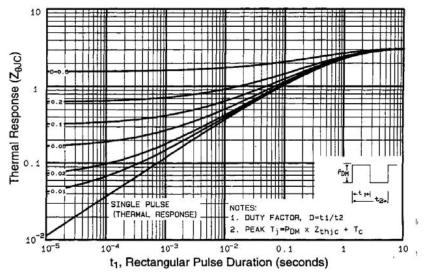


Fig. 10b - Switching Time Waveforms





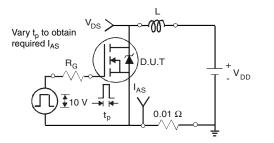
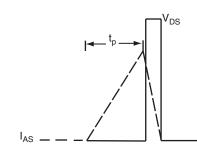


Fig. 12a - Unclamped Inductive Test Circuit





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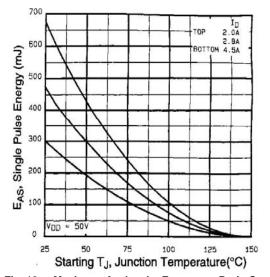


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

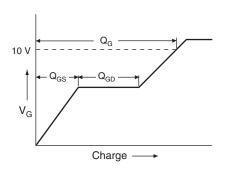
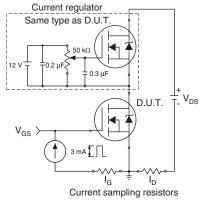


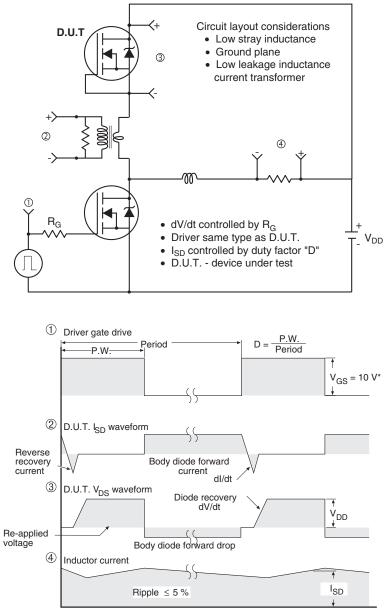
Fig. 13a - Basic Gate Charge Waveform







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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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